

## **FDS6676S**

# 30V N-Channel PowerTrench $^{o}$ SyncFET $^{m}$

## **General Description**

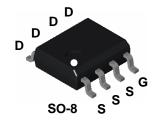
The FDS6676S is designed to replace a single SO-8 MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\text{DS(ON)}}$  and low gate charge. The FDS6676S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology.

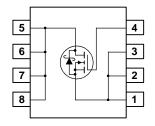
## **Applications**

- DC/DC converter
- Motor drives

## **Features**

- 14.5 A, 30 V.  $R_{DS(ON)}$  7.5 m $\Omega$  @  $V_{GS}$  = 10 V  $R_{DS(ON)}$  9.0 m $\Omega$  @  $V_{GS}$  = 4.5 V
- Includes SyncFET Schottky body diode
- Low gate charge (43nC typical)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$  and fast switching
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±16	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	14.5	А
	- Pulsed		50	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range		−55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	25	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity	
FDS6676S	FDS6676S	13"	12mm	2500 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics		•	l .		
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = 1 \text{ mA}$	30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C		21		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			500	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 16 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -16 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	1	1.4	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, Referenced to 25°C		-3.8		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{aligned} &V_{GS} = 10 \text{ V}, & I_{D} = 14.5 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, & I_{D} = 13.2 \text{ A} \\ &V_{GS} = 10 \text{ V}, I_{D} = 14.5 \text{A}, T_{J} = 125 ^{\circ}\text{C} \end{aligned}$		5.25 6.0 8.0	7.5 9.0 12	mΩ
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	50			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 14.5 \text{ A}$		80		S
Dynamic	Characteristics		•			
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ f = 1.0 MHz		4665		pF
C <sub>oss</sub>	Output Capacitance			826		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			304		pF
R <sub>G</sub>	Gate Resistance	$V_{GS} = 15 \text{ mV}, \qquad f = 1.0 \text{ MHz}$		1.4		Ω
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		11	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		10	20	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			82	131	ns
t <sub>f</sub>	Turn-Off Fall Time			30	48	ns
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 14.5 \text{ A}, \\ V_{GS} = 5 \text{ V}$		43	60	nC
Q <sub>gs</sub>	Gate-Source Charge			10		nC
$Q_{gd}$	Gate-Drain Charge			11		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 3.5 \text{ A}  \text{(Note 2)}$ $V_{GS} = 0 \text{ V},  I_S = 7 \text{ A}  \text{(Note 2)}$		390 490	700	mV
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 14.5A,		31		nS
I <sub>RM</sub>	Diode Reverse Recovery Current	$d_{iF}/d_t = 300 \text{ A/}\mu\text{s} \qquad (Note 3)$		1.8		Α
Q <sub>rr</sub>	Diode Reverse Recovery Charge	7		30		nC

1. R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 50°/W when mounted on a 1 in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper



c) 125°/W when mounted on a minimum pad.

See "SyncFET Schottky body diode characteristics" below

Scale 1 : 1 on letter size paper

Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

## **Typical Characteristics**

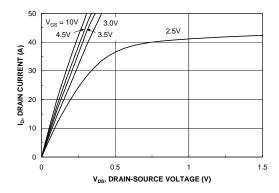


Figure 1. On-Region Characteristics.

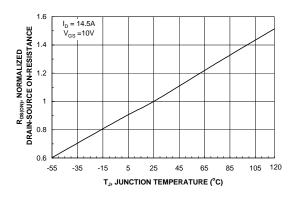


Figure 3. On-Resistance Variation with Temperature.

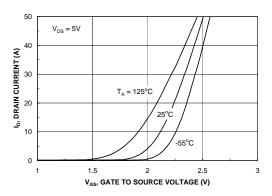


Figure 5. Transfer Characteristics.

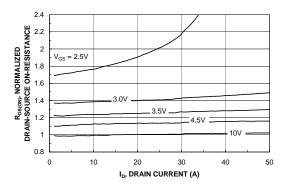


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

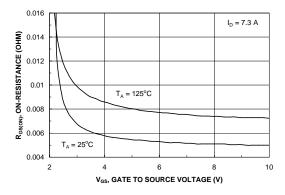


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

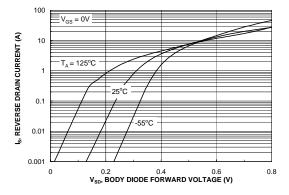
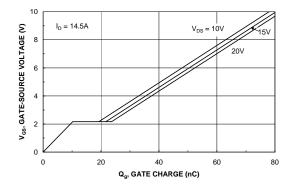


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics (continued)



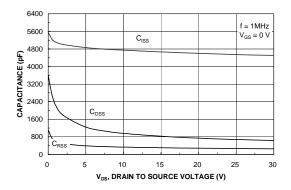


Figure 7. Gate Charge Characteristics.

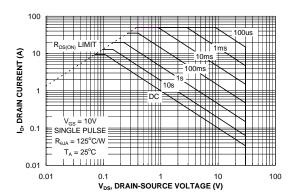


Figure 8. Capacitance Characteristics.

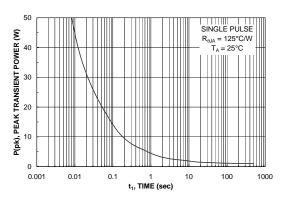


Figure 9. Maximum Safe Operating Area.



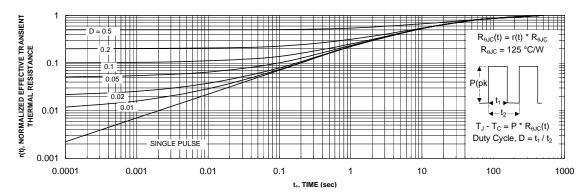


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

## Typical Characteristics (continued)

# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6676S.

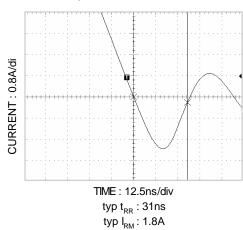


Figure 12. FDS6676S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6676).

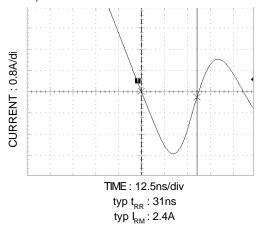


Figure 13. Non-SyncFET (FDS6676) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

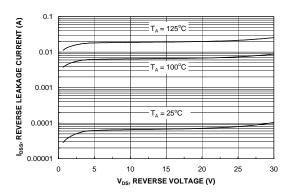


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

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